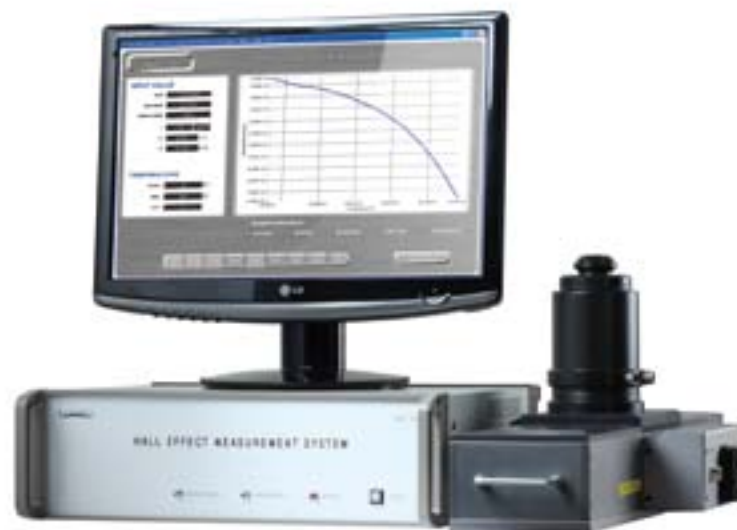


Hall Effect Measurement System

Model No: HMS5000/AMP55T

Very competitive price.
Easy-to-Use
Compact Desktop Design,
Powerfully performing Instrument
Always best customer service



Ecopia's Hall Effect Measurement Systems are complete systems for measuring the resistivity, carrier concentration, hall coefficient, mobility and N / P type decision of semiconductor samples.

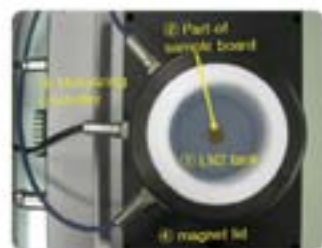
Consists of

- 1) Main body system.
Constant current source + Van der Pauw method terminal conversion system
- 2) 0.55Tesla Magnet Kit (Model No: AMP55T)
Magnet flux density: 0.55Tesla
Gap between round magnet: 26mm / Round magnet diameter: 50mm
Measurable temp: 80K ~ 350K. Accuracy: +/- 0.5°C
This AMP55T can be compatible with HMS5000.
The magnet moves automatically by controlling on s/w, PC.
Sample holder, LN2 tank (Round LN2 tank and Square LN2 tank) were integrated with magnet kit.



Sample mounting kit construction

- Round LN2 tank
- Phosphorous copper sample mounting board,
- temperature sensor
- heater.
- magnet Lid
- cable



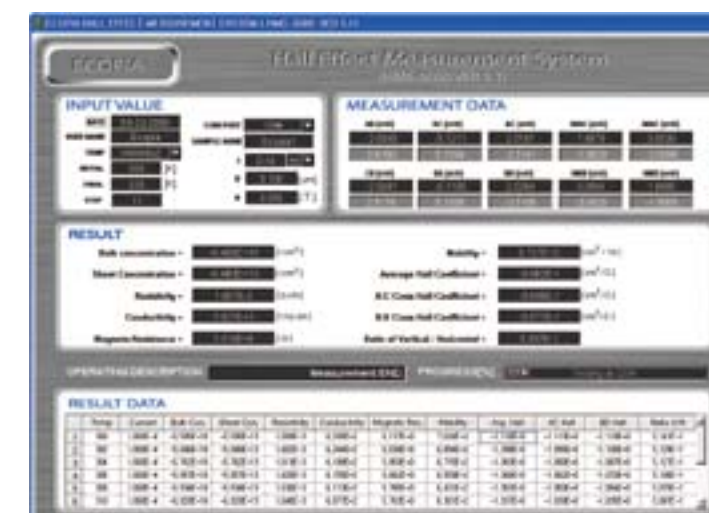
AMP Magnet kit top view

- Motorizing magnet controller.
- Round type LN2 tank.
- Magnet lid.
- Cable



- 3) Sample board with magnet lid only for Room Temperature test
 - Optional accessory (Not included HMS5000 full set)
 - When you test at RT (Room Temp), you can use this optional accessory by exchanging sample holding kit of AMP55 (magnet kit of HMS5000).

- 4) S/W program.



HMS5000 model's test main page



I-V, I-R graph as per temp variation



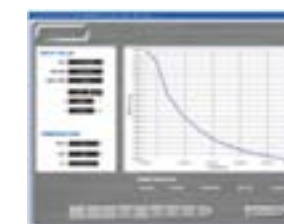
Resistivity vs temp variati



Carrier concentration vs temp variation



Hall Coefficient vs temp variation



Mobility vs temp variatio



Conductivity vs temp variation

Model No: HMS3300/ HT55T

Product Specifications

1) General Factors

Input Curren	Resistivity (Ω cm)	Carrier Concentration (1/cm3)	Mobility (cm2/Volt·sec	Magneto Flux Density(T)	Temperature (K)	Sample Testing Boar
1nA - 20mA	10 ⁻⁴ ~ 10 ⁷	10 ⁷ ~ 10 ²¹	1 ~ 10 ⁷	0.55Tesla only	80K ~ 350K. +/-0.5°C accuracy	5 x 5mm ~ 20 x 20mm Less than 2mm thickness sample

2) Sample Structure

3D of Measurement Sample

3) S/W Operation Environment

Windows 98 / ME / 2000 / NT / XP / VISTA

4) Data Index

- N / P type decision
- Bulk, Sheet Carrier Concentration
- Resistivity
- Mobility, Hall Coefficient
- Magneto resistance
- The ratio of Vertical/Horizontal resistance value)

5) Dimension

- Mainbody(HMS5000)
- Size: 440 x 420×140 mm (W×H×D) / Weight : 8.5 kg
- Magnet Kit
- Size: 700×220×280 mm (W×H×D) / Weight : 15.5 kg

6) Materials for Measurement

Si, SiGe, SiC, GaAs, InGaAs, InP, GaN, TCO(including ITO), AlZnO, FeCdTe, ZnO and all of semiconductors.

Certificate of the performance

1- Acquired CE Mark:

We 've acquired HMS5000 model's CE mark on Oct, 2009year to export to European countries.

2- Patent :

We already applied for the Korean government to acquire patent.

Model No: HMS3300/ HT55T



HMS3000's main body system image

And, Model No. "HMS3300/HT55T" consists of "Model No. HMS3000's main body system" plus "Model No HT55T" magnet and accessories.



"NEW" Model No: HT55T

Magneto flux density: 0.55Tesla
Two 0.55T magnets on a ball bearing slide are included.
Measurable temp: RT ~ 300°C . Accuracy: 0.1°C
This HT55T can be compatible with existing HMS-3000 systems.
If you already purchased HMS3000 system and you are interested in variably high temperature test (max 300°C), we recommend you to purchase this magnet kit (Model No: HT55T)



HT55T's sample board and inside view

- Both round magnet was horizontally positioned as opposed to MS55T and AMP55T
- The temperature is set manually and controlled via the digital controller.



Magnet introduced from North to South Polarty



Magnet introduced from South to North Polarty

Model No: HMS3000/ HT55T



HMS3000 main body

1) S/W Operation Environment

Windows 98 / ME / 2000 / NT / XP / VISTA

2) Data Index

- N/P type decision.
- Bulk, Sheet Carrier Concentration
- Resistivity
- Mobility, Hall Coefficient
- Magneto resistance
- The ratio of Vertical/Horizontal resistance value)

3) Size

360×300×105 mm (W×H×D), Weight : 7.7 kg

4) Materials for Measurement

Si, SiGe, SiC, GaAs, InGaAs, InP, GaN, ITO, ZnO and all of semiconductors.

Technical specs

Input Curren	Resistivity (Ω cm)	Carrier Concentration (1/cm ³)	Mobility (cm ² /Volt·sec	Magneto Flux Density(T)	Temperature (K)	Sample Testing Boar
1nA - 20mA (HMS3000)	10 ⁻⁴ ~ 10 ⁷	10 ⁷ ~ 10 ²¹	1 ~ 10 ⁷	MS31T MS37T MS55T MS100T MP55T HT55T	77K(LN2), 300K(RT)	SPCB-00 SPCB-01 SPCB-02 SPCB-03 SPCB-11 SPCB-12 SPCB-13 Max 30mm size sample Max 5.5mm thickness sample.
10nA - 20mA (HMS2000)						



Test main page s/w



I-V, I-R Curve test page

* Magnet

- HMS3000 main body system can be complete system by intergrating with magne kit, mentioned above, such as MS31T ~ HT55T

* Sample Testing Board and accessories

- We provide various size of sample testing board and electrical conductives to improve ohmic contact, such as InSn compound, Carbon paste, gold paste and etc.

Model No: HM S2000



HMS2000 main body



Test main page s/w

* Technical specs

- Input current range: 10nA ~ 20mA - Auto/ Manual alternatively
- Good to use for education purpose.

Magnet series

* General Specs

- Permanent magnet
- Neodium materials.
- Magneto flux density lose its power only 0.2% per 1year.
- Magneto flux density may differ within the range of
- +/-0.03Tesla in a process of assembling magnet.

Model No: MS31T, MS37T, MS55T

Magneto flux density :

0.31T,0.37T, 0.55Tesla

Gap between round magnet : 26mm

Measurable temp : 77K, RT.

Same construction each other.

Compatible with HMS3000 system.



Model No: MS100T

Magneto flux density : 1.0Tesla

Gap between round magnet : 6mm /

Measurable temp : RT only.

Compatible with HMS3000 system



Model No: MP55T

Magneto flux density : 0.55Tesla

Gap between round magnet : 26mm

Measurable temp : 77K, RT.

Two 0.55T magnets on a ball bearing slide are included.

Compatible with HMS3000 system.



"NEW" Model No : HT55T

Magneto flux density : 0.55Tesla

Two 0.55T magnets on a ball

bearing slide are included.

Measurable temp : RT ~ 300°C

Accuracy : 0.1°C

This HT55T can be compatible with existing HMS-3000 systems.



Model No: AMP55T

Magneto flux density : 0.55Tesla

Gap between round magnet : 26mm/

Round magnet diameter : 50mm

Measurable temp : 80K ~ 350K.

Accuracy : +/- 0.5°C

This AMP55T can be compatible with HMS5000.

The magnet moves automatically by controlling on s/w, PC.

Sample holder, LN2 tank (Round LN2 tank and Square LN2 tank) were integrated with magnet ki

SPCB sample board series.

* General Specs

- Mount samples upto 5x 5mm ~ 20 x 20mm square without using bond wires.
- Spring loaded clamps and tips make contact
- Gold plated Non-magnetic phosphor-bronze construction
- Contacts on four sample's corner may still be required for good contact



Model No: SPCB-01

Compatible with 0.31T,0.37T, 0.55T magnet kit.

Measurable sample thickness : less than 2mm



Model No: SPCB-02, SPCB-03

Compatible with 0.31T,0.37T, 0.55T magnet kit.

Measurable sample thickness : 2~4.5mm, 3~ 5.5mm



Model No: SPCB-01

Compatible with 0.31T,0.37T, 0.55T and 1.0T magnet kit.

Measurable sample thickness : less than 1.5mm

Ecopia' s items that we have made and installed

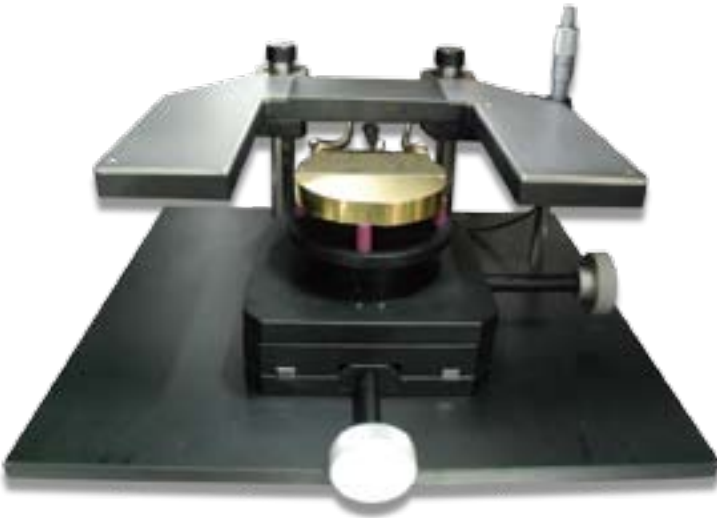
HMS 2000 Hall Effect system 	10nA ~ 20mA Auto/Manual alternatively	HMS 3000 Hall Effect system 	1nA ~ 20mA Auto type. Best-selling mode	NEW HMS 5000 Hall Effect system 	Variable temp 80 K ~ 350 K. +/-0.5° C accuracy
SPCB and accs 	5x5mm~20x20mm Gold coated probe tip Very convenient to use	MS 55T and more Magnet Kit 	We have more, such as, 0.31T, 0.37T, 1.0T and MP 55T	NEW HMS3300 High temp Hall Effect system 	RT ~ 300 °C. Manual It can be used with HMS3000 main body
EPS 300 Probe station 	Reasonable price and compact design	EPS 500 Probe station 	0 °C~ 300 °C We have mor	EPS 1000 Probe station 	RT~ 300 °C We have more
EMP-7, EMP-9 Manipulator 	Reasonable price including probe arm, tip and cable	ETCP 1000 Heating and cooling probe station 	Reasonable price including probe arm, tip and cable.	RTP1000 Rapid Thermal Processor 	RT ~ 1200 °C 1000 °C /40seconds
RTP 2000 Controlled by PC s/w. 	RT ~ 1200 °C 1000 °C /40seconds	ELT-1000 LED Tester 	IV, IR curve, Optical characteristic	NEW HMS5300 High temp Hall Effect system 	RT ~ 300 °C. Controlled by PC. Use with HMS5000
Electro - conductives. 	To improve ohmic contact by electrical conductivity materials. We have more such as Gold paste, Carbon paste	Dark Box and accs 	We have more accs for probe station, such as probe tip, Triaxial cable	Custom - made 	- Photonic hall effect - Integrating sphere system - Photo detector test system

Probe Station

Model No: ETCP-1000

Probe Station is test system which is used to get the electrical characteristics of semiconductor samples , such as I-V and I-R properties of semiconductor wafer or device.

It can make it possible to probe even micro distance and contact on semiconductor sample by using microscope and manipulator



Heating and Cooling System



Probe station and chamber inside



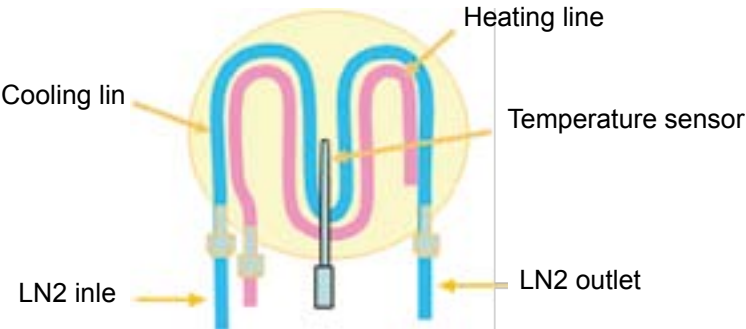
Vacuum chamber view



LN2 container



Temperature controller



Heating and cooling chuck

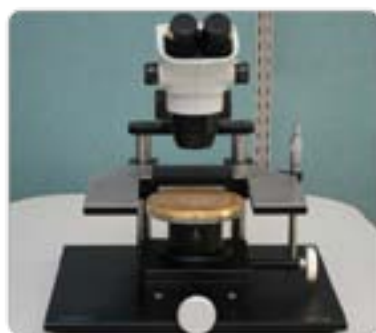
- 1) Heating & Cooling Chuck
 - Variable Temp : 80K~500K),
 - Resolution : +/- 0.1°C
- 2) Vacuum Chamber to have enough room to make LED testing system inside of chamber.
- 3) Semi-Auto type Manipulator operated by motorizing system (Option)
- 4) Glass window that make it easy to see through in Vacuum chamber.
- 5) Useful connector that installed at the chamber wall, to make feed-through which can make it easy to apply DC,RF signal.

Various Heating and Cooling System Probe Station



Model No: EPS1000

- Reasonable price and compact design
- 4inch, 6inch, 8inch chuck alternatively.
- RT ~ 300°C heating chuck as option.
- 0 °C ~ 300 °C heating and cooling chuck as option
- Maximum 6ea manipulators can be installed.



Model No: EPS500(general type)

- Reasonable price and compact design
- 4inch, 6inch, 8inch chuck alternatively.
- RT ~ 300°C heating chuck as option.
- 0 °C ~ 300 °C heating and cooling chuck as option
- Max 6manipulator can be installed



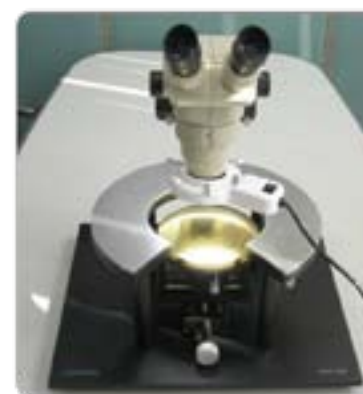
Model No: EPS500 (Heating & Cooling Chuck)

- Reasonable price and compact design
- 6 inch chuck
- 0 °C ~ 300 °C heating and cooling chuck was installed in the left image. Chiller, dryer and air compressor also needed. (Humidity removal as option)
- Magnify : x 120 microscope (trinocular type) was installed



Model No: EPS500 (High quality microscope)

- Reasonable price and compact design
- 4~ 8 inch chuck can be installed.
- RT ~ 300°C heating chuck as option.
- 0 °C ~ 300 °C heating and cooling chuck as option
- High quality BXM microscope (Olympus) was installed.



Model No: EPS300

- Reasonable price and compact design
- 4 inch, 6 inch chuck alternatively.
- RT ~ 300°C heating chuck as option.
- 0 °C ~ 300 °C heating and cooling chuck as option
- Max 6 manipulator can be installed.

Microscope

- We can provide more various microscope as per customer's request, from reasonable price to high quality microscope, such as Olympus.
- Magnification : x 90 ~ x 1,000
- CCD (option)

Custom-made system

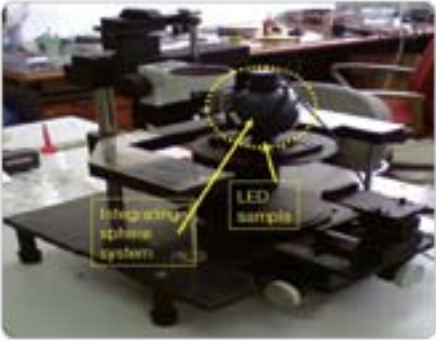
We have made and installed various "custom-made" systems, and we introduce below two systems, although below two systems are not the all that we have, and we have mores...

If you are interested in decorating your own system to meet your needs, please do not hesitate to contact us.



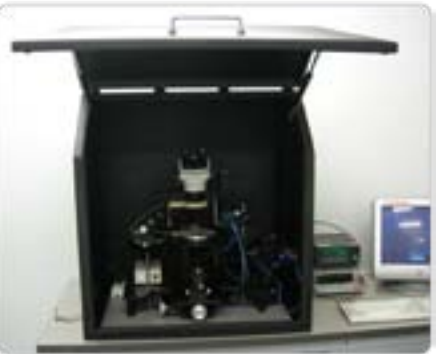
"Photo detector" test system with probe station

- By using Optical power and cable.
- Illuminate light onto "photo detector sample" and read "current".



Integrating sphere system with probe station.

- Integrating system can be put on either sample's above or below as per user's request.
- Very useful testing system for optical characteristics (Spectra, Light Intensity) of the LED chip, Lamp, SMD Type



Dark Box

- Size : 750 x 660 x 660 mm
- Material : Steel
- We can provide various size of dark box as required customer's needs.

Isolation table

- Anti-vibration table
- We also can provide anti-vibration table as required customer's needs, although the image was not loaded in this page.

Manipulator

As one of the most important part in Probe_Station, manipulator is an accurately probing system that can probe even micro distance(μm) and contact on the electrode of semiconductor wafer, device.

ECOPIA's Manipulator is very easy to use and probe arm's elastic plate function as protecting sample's surface, from damage during Z axis movement.



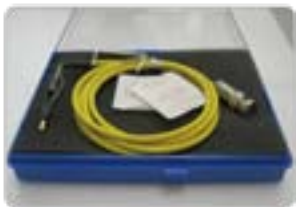
Model No: EMP-7



Model No: EMP-9



Probe arm with BNC cable



Probe arm with Triaxial cable



Probe tip

- 1- X.Y.Z travel: 10 x 10 x 10mm
- 2- Probe arm Holder
- 3- X, Y, Z Fine motion control(5μm/pitch)
- 4- Manipulator frame body
- 5- Probe Arm (Elastic plate)
- 6- Magnets for firmly fixing manipulator onto probe station's base unit.
- 7- Probe tip assembly
- 8- Electrical noise: Less than 300fA.

Technical specs comparison among standard models

	EPS300	EPS500	EPS1000	Remark
1) Chuck siz	4inch (100mm)	6inch (150mm)	6inch (150mm)	8 inch (200mm) chuck is option
2) Microscope Mount X.Y Stage	O	O	O	Option
3) Microscope	X 90 ~ X 1,000	X 90 ~ X 1,000	X 90 ~ X 1,000	Option
4) CCD camera	O	O	O	Option
5) Chuck rotation	N/A	360° rotation	360° rotation	
6) X,Y, Z travel	X : 50mm Y : 50mm Z : 12mm	X : 100mm Y : 100mm Z : 25mm	X : 100mm Y : 100mm Z : 40mm	
7) Heating chuck (RT~300°C)	O	O	O	Option
8) Heating chuck (0°C~300°C)	O	O	O	Option. Heating & Cooling capability
9) Size and Weight	Similar with EPS500	450 x 500 x 550 (mm) 13~15KG	575 x 485 x 430 (mm) 27KG	It may differ as per option specs.